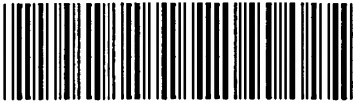


**Search Notes**

Application/Control No.

10/777,352

Examiner

Cong-Lac Huynh

Applicant(s)/Patent under  
Reexamination

DENOUE ET AL.

Art Unit

2178

**SEARCHED**

Class	Subclass	Date	Examiner
715	500	11/14/2007	CLH
	512	11/14/2007	CLH
	541	11/14/2007	CLH
382	188	11/14/2007	clh

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
715	512	11/14/2007	CLH
Interference Search History Printout		11/21/2007	CLH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (USPAT, USPGPUB, JPO, EPO, Derwent)	11/14/2007	CLH
ACM	11/14/2007	CLH